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Boost Chopper with Field Stop Trench IGBT + SiC SBD

$V_{CES} = 1200V$
 $I_C = 80A @ T_C = 100^{\circ}C$



Features

- **Field StopTrench Fast IGBT**
 - Low voltage drop
 - Low tail current
 - Switching frequency up to 50 kHz
 - Low leakage current
- **Chopper SiC Schottky Diode**
 - Zero reverse recovery current
 - Temperature Independent switching behavior
 - Positive temperature coefficient on VF

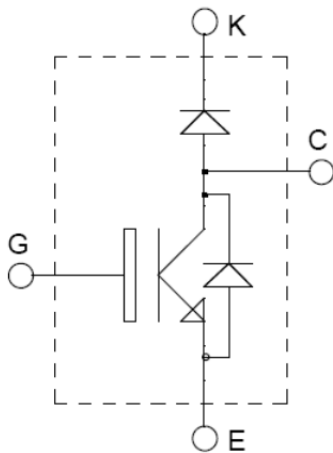
Applications

- Solar inverters
- AC and DC motor control
- Power Factor Correction
- Aerospace Actuators



Benefits

- Outstanding performance at high frequency operation
- Low switching losses
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive T_C of V_{CESat}
- RoHS Compliant



Absolute Maximum Ratings ($T_j=25^{\circ}C$ unless otherwise specified)

| Parameters | Symbol | Conditions | Specifications | Units |
|---------------------------------------|-----------|----------------------|----------------|-------------|
| Collector - Emitter Breakdown Voltage | V_{CES} | | 1200 | V |
| Continuous Collector Current | I_C | $T_C = 25^{\circ}C$ | 160 | A |
| | | $T_C = 100^{\circ}C$ | 80 | A |
| Gate-Emitter Voltage | V_{GES} | | ± 20 | V |
| Pulsed Collector Current | ICM | | 240 | A |
| Maximum Power Dissipation | P_D | $T_C = 25^{\circ}C$ | 480 | W |
| | | $T_C = 100^{\circ}C$ | 200 | W |
| Operating Junction Temperature | T_J | | -55 ~ 150 | $^{\circ}C$ |
| Storage Temperature | T_{STG} | | -55 ~ 150 | $^{\circ}C$ |

Electrical Characteristics ($T_J=25^{\circ}\text{C}$ unless otherwise specified)

| Parameters | Symbol | Conditions | Min | Typ | Max | Units |
|--------------------------------------|---------------|--|-----|------|-----------|---------------|
| OFF | | | | | | |
| Zero Gate Voltage Collector Current | I_{CES} | $V_{CE} = 1200\text{V}, V_{GE} = 0\text{V}$ | -- | -- | 2 | mA |
| Gate-Emitter Leakage Current | I_{GES} | $V_{CE} = 0\text{V}, V_{GE} = 20\text{V}$ | -- | -- | ± 500 | nA |
| ON | | | | | | |
| Gate-Emitter Threshold Voltage | $V_{GE(TH)}$ | $V_{GE} = V_{CE}, I_C = 80\text{mA}$ | 4.5 | 6.5 | 8.5 | V |
| Collector-Emitter Saturation Voltage | $V_{CE(SAT)}$ | $V_{CE} = 15\text{V}, I_C = 80\text{A}, T_J = 25^{\circ}\text{C}$ | -- | 2.0 | 2.6 | V |
| | | $V_{CE} = 15\text{V}, I_C = 80\text{A}, T_J = 125^{\circ}\text{C}$ | -- | 2.45 | -- | V |
| DYNAMIC | | | | | | |
| Input Capacitance | C_{IES} | $V_{CE} = 30\text{V}, V_{GE} = 0\text{V}, f = 1\text{MHz}$ | -- | 10.3 | -- | nF |
| Output Capacitance | C_{OES} | | -- | 300 | -- | pF |
| Reverse Transfer Capacitance | C_{RES} | | -- | 200 | -- | pF |
| SWITCHING | | | | | | |
| Turn-On Delay Time | $t_{d(on)}$ | $V_{CE} = 600\text{V}, I_C = 80\text{A}$ $R_G = 10\Omega, V_{GE} = 15\text{V}$ Inductive Load, $T_J = 25^{\circ}\text{C}$ | -- | 60 | -- | ns |
| Rise Time | t_r | | -- | 85 | -- | ns |
| Turn-Off Delay Time | $t_{d(off)}$ | | -- | 200 | -- | ns |
| Fall Time | t_f | | -- | 60 | -- | ns |
| Turn-On Switching Energy Loss | E_{ON} | | -- | 7.1 | -- | mJ |
| Turn-Off Switching Energy Loss | E_{OFF} | | -- | 1.2 | -- | mJ |
| Turn-On Delay Time | $t_{d(on)}$ | $V_{CE} = 600\text{V}, I_C = 80\text{A}$ $R_G = 10\Omega, V_{GE} = 15\text{V}$ Inductive Load, $T_J = 125^{\circ}\text{C}$ | -- | 50 | -- | ns |
| Rise Time | t_r | | -- | 80 | -- | ns |
| Turn-Off Delay Time | $t_{d(off)}$ | | -- | 210 | -- | ns |
| Fall Time | t_f | | -- | 120 | -- | ns |
| Turn-On Switching Energy Loss | E_{ON} | | -- | 7.6 | -- | mJ |
| Turn-Off Switching Energy Loss | E_{OFF} | | -- | 2.4 | -- | mJ |
| Total Gate Charge | Q_g | $V_{CE} = 600\text{V}, I_C = 80\text{A}$ $V_{GE} = 15\text{V}$ | -- | 640 | 960 | nC |
| Gate-Emitter Charge | Q_{ge} | | -- | 80 | 120 | nC |
| Gate-Collector Charge | Q_{gc} | | -- | 300 | 450 | nC |
| Short Circuit Withstanding Time | t_{sc} | $V_{CE} = 600\text{V}, V_{GE} = 15\text{V}$ $T_J = 125^{\circ}\text{C}$ | -- | -- | 10 | μs |

SiC Diode Rating and Characteristics ($T_j=25^{\circ}\text{C}$ unless otherwise specified)

| Parameters | Symbol | Conditions | Min | Typ | Max | Units |
|---|-----------|--|------|------|-----|---------------|
| Maximum peak repetitive reverse voltage | V_{RRM} | | 1200 | -- | -- | V |
| Maximum Reverse Leakage Current | I_{RM} | $V_R = 1200\text{V}, T_j = 25^{\circ}\text{C}$ | -- | 20 | 200 | μA |
| | | $V_R = 1200\text{V}, T_j = 150^{\circ}\text{C}$ | -- | 2424 | -- | μA |
| Diode Forward Voltage | V_F | $I_F = 40\text{A}, T_j = 25^{\circ}\text{C}$ | -- | 1.5 | 1.7 | V |
| | | $I_F = 40\text{A}, T_j = 150^{\circ}\text{C}$ | -- | 2.3 | -- | V |
| Total Capacitive Charge | Q_C | $V_R=1200\text{V}, I_F<I_{F,max}$ | -- | 208 | -- | nC |
| Switching Time | t_C | $di_F/dt = 200\text{A}/\mu\text{s}, T_j = 175^{\circ}\text{C}$ | -- | -- | 20 | ns |
| Total Capacitance | C | $V_R = 1\text{V}, f = 1\text{MHz}$ | -- | 3600 | -- | pF |
| | | $V_R = 600\text{V}, f = 1\text{MHz}$ | -- | 228 | -- | pF |
| | | $V_R = 1200\text{V}, f = 1\text{MHz}$ | -- | 172 | -- | pF |

Thermal and Package Characteristics ($T_j=25^{\circ}\text{C}$ unless otherwise specified)

| Parameters | Symbol | Conditions | Min | Typ | Max | Units |
|-------------------------------------|------------|--|------|-----|------|-----------------------------|
| Junction to Case Thermal Resistance | R_{THIC} | IGBT chip | -- | -- | 0.26 | $^{\circ}\text{C}/\text{W}$ |
| | | SiC SBD chip | -- | -- | 0.49 | $^{\circ}\text{C}/\text{W}$ |
| Mounting Torque | M_d | | | | 1.5 | N-m |
| Terminal Connection Torque | M_{dt} | | 1.3 | -- | 1.5 | N-m |
| Package Weight | W_t | | | 29 | | g |
| Isolation Voltage | V_{ISOL} | $I_{ISOL} < 1\text{mA}, 50/60\text{Hz}, t=1\text{min}$ | 2500 | V | | |

IGBT Characteristics (2*40A dies in parallel)

Fig. 1 Output characteristics

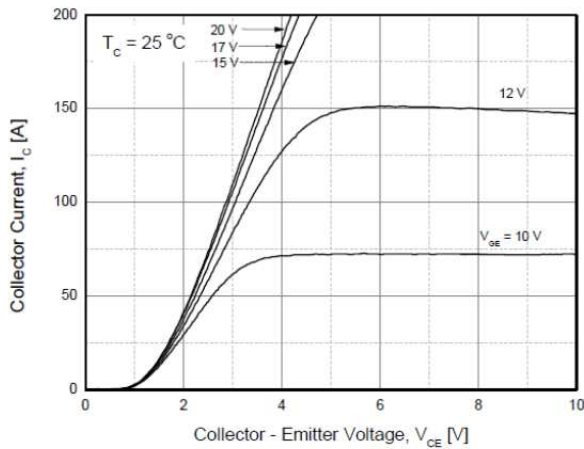


Fig. 2 Saturation voltage characteristics

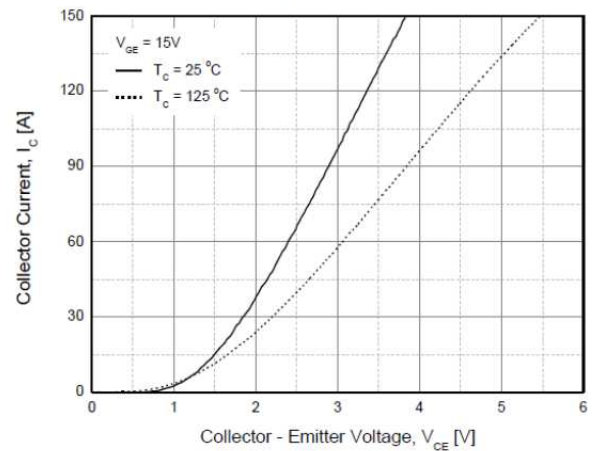


Fig. 3 Saturation voltage vs. collector current

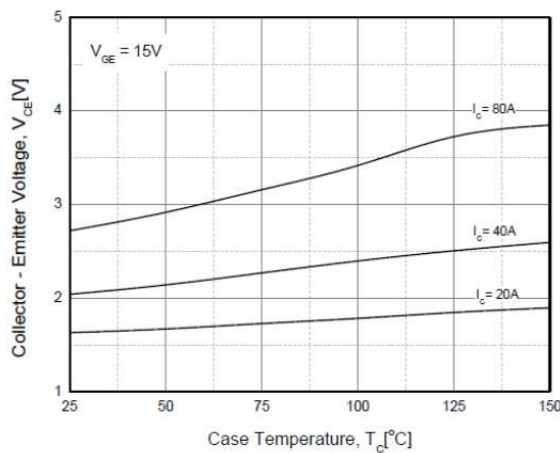


Fig. 4 Saturation voltage vs. gate bias

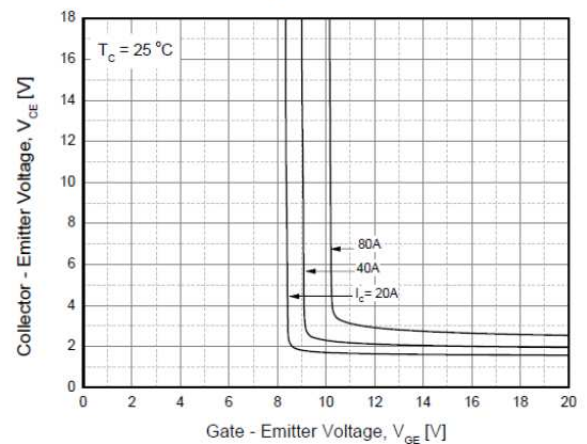


Fig. 5 Saturation voltage vs. gate bias

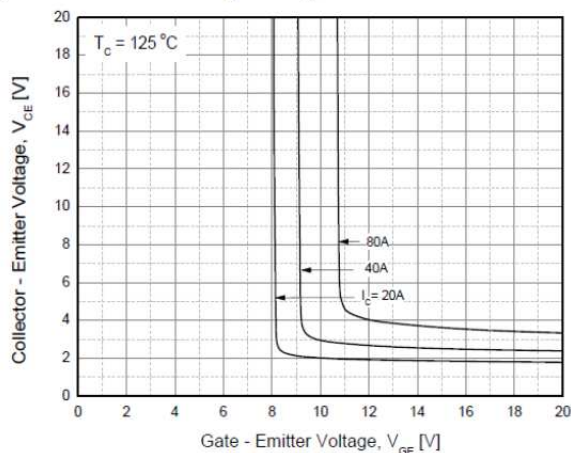


Fig. 6 Capacitance characteristics

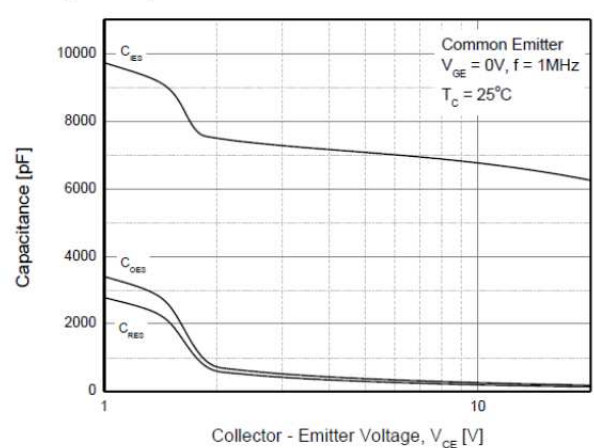


Fig. 7 Turn-on time vs. gate resistor

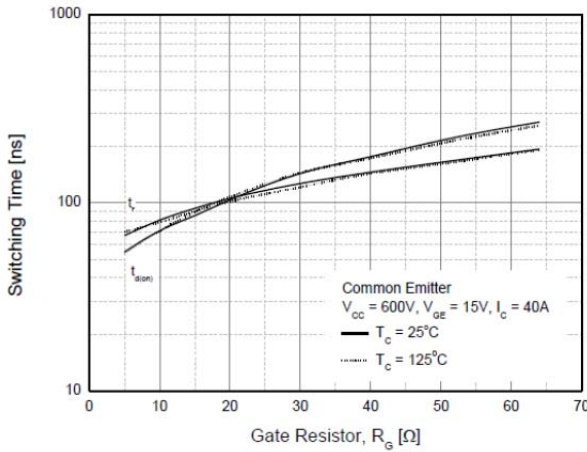


Fig. 8 Turn-off time vs. gate resistor

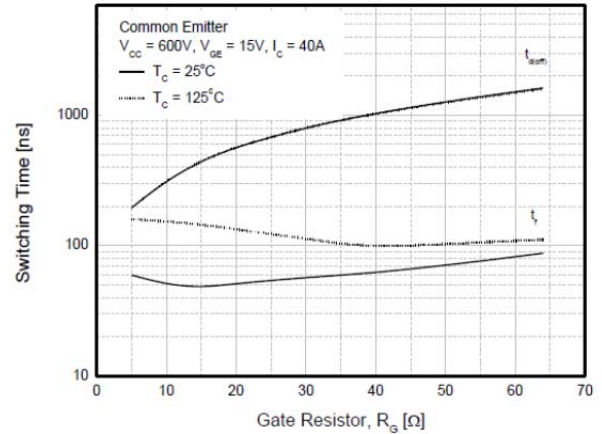


Fig. 9 Switching loss vs. gate resistor

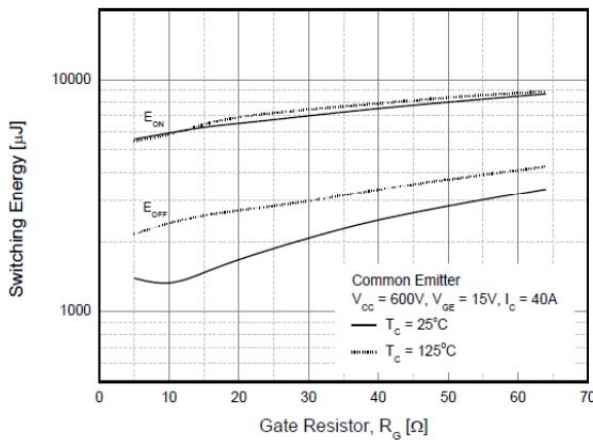


Fig. 10 Turn-on time vs. collector current

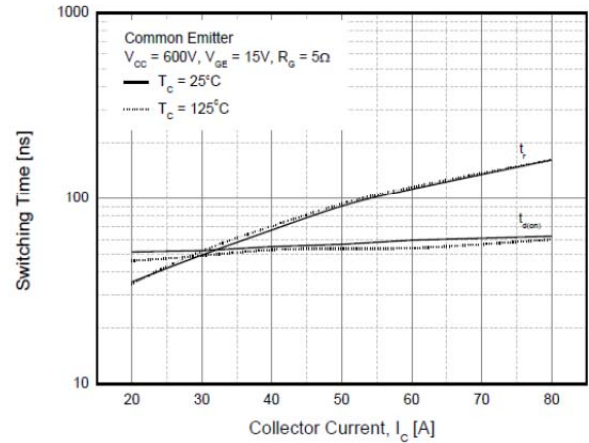


Fig. 11 Turn-off time vs. collector current

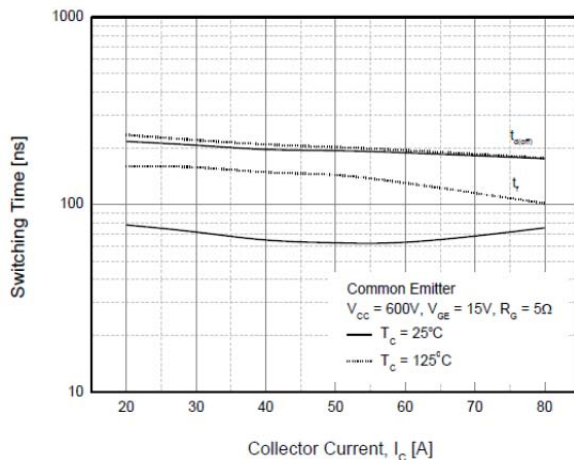


Fig. 12 Switching loss vs. collector current

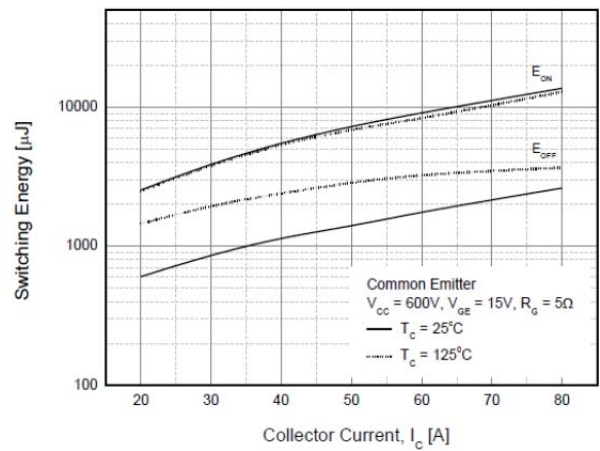


Fig. 13 Gate charge characteristics

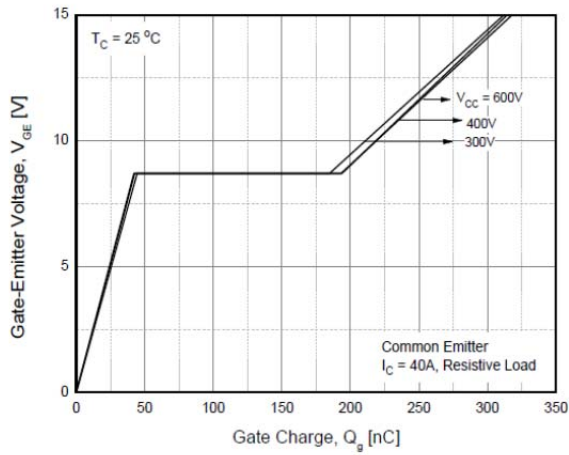


Fig. 14 SOA

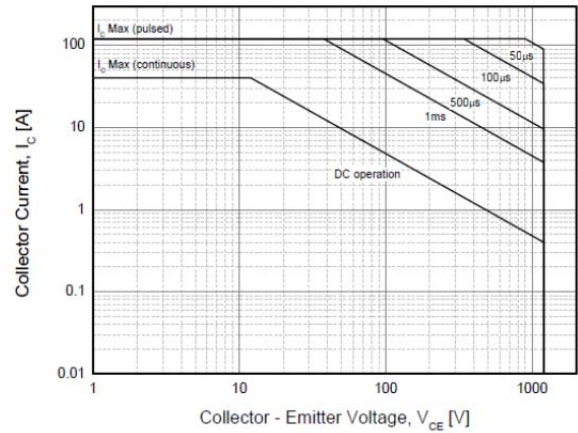


Fig. 15 RBSOA

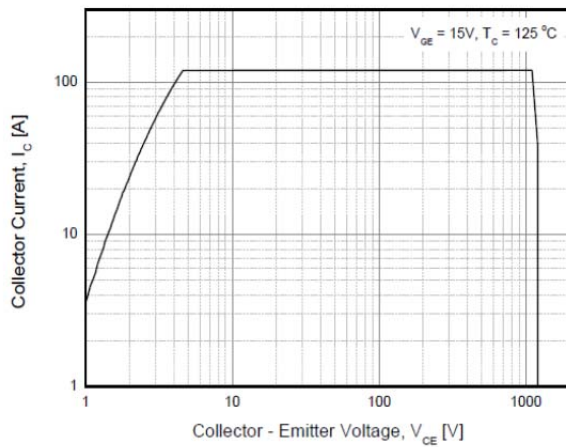
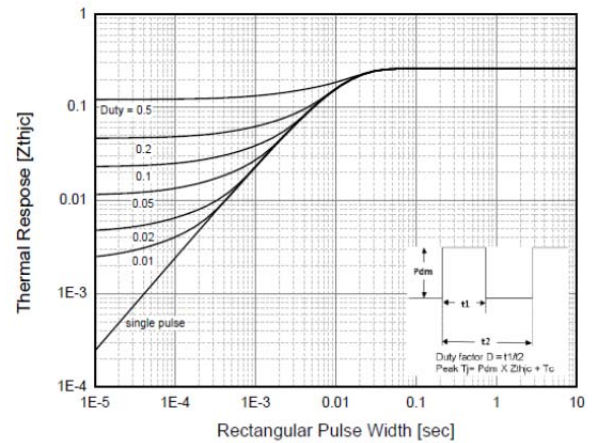


Fig. 16 Transient thermal impedance of IGBT



Boost SiC Diode Characteristics (2*20A dies in parallel)

Fig. 17 Forward Characteristics

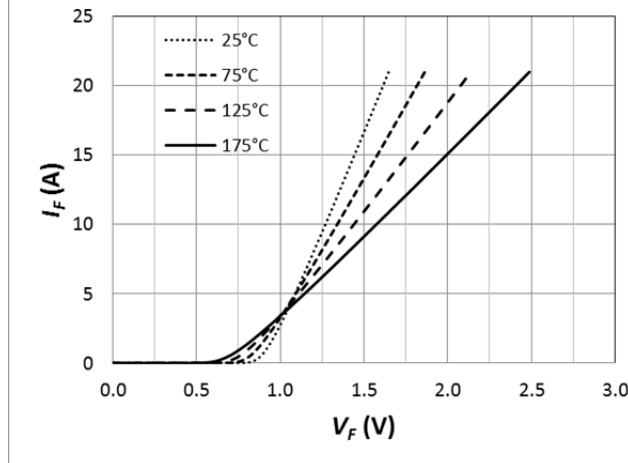


Fig. 18 Reverse Characteristics

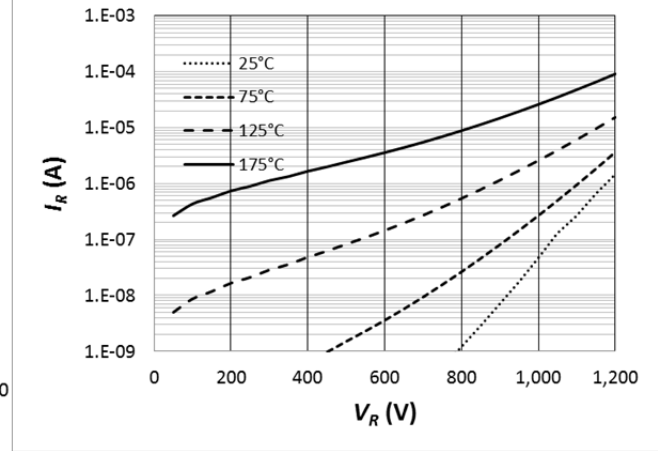


Fig. 19 Power Derating

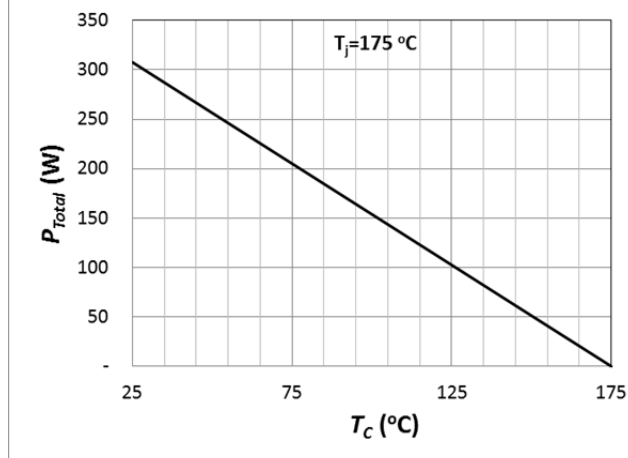


Fig. 20 Current Derating

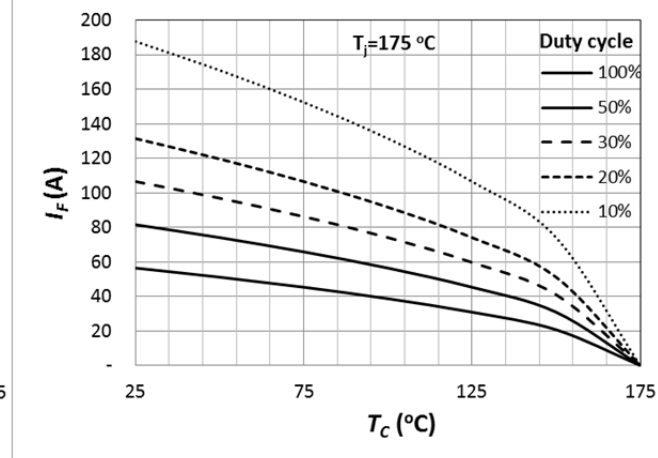


Fig. 21 Capacitance Curve

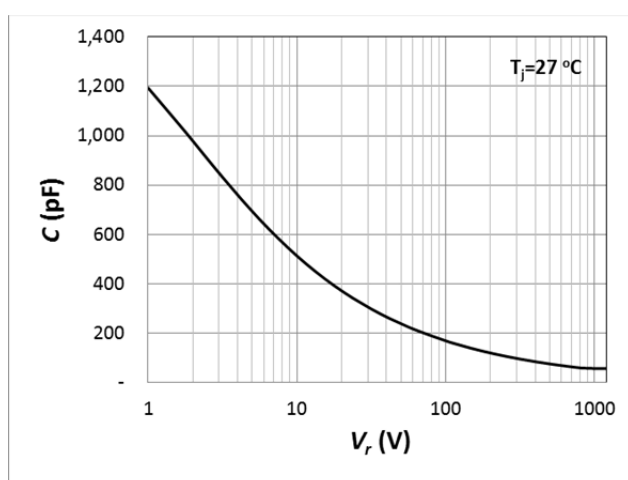
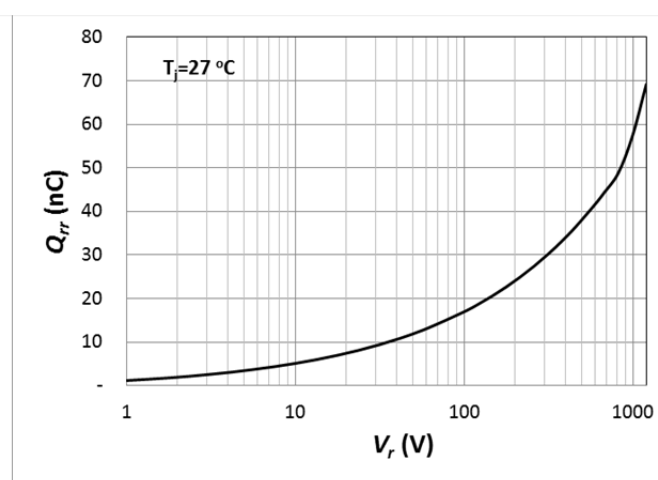
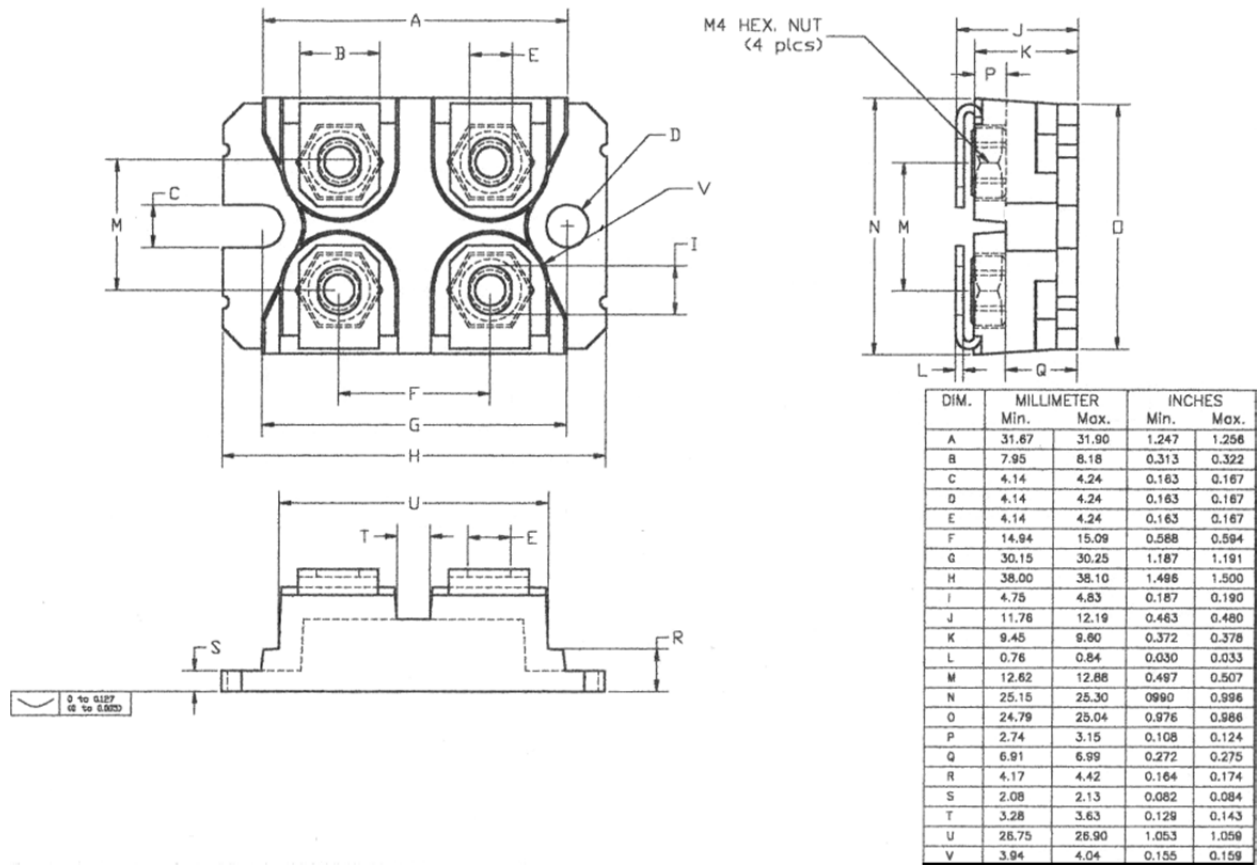


Fig. 22 Recovery Charge



SOT-227 Package Outline



Revision History

| Date | Revision | Notes |
|----------|----------|-----------------|
| 6/3/2014 | 1.0 | Initial release |
| | | |
| | | |

To obtain additional technical information or to place an order for this product, please contact us. The information in this datasheet is provided by Global Power Electronics, Inc. GPE reserves the right to make changes, corrections, modifications, and improvements without notice.

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